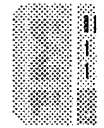


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Bhatnagar, R.; Kanal, L.N.;

Uncertainty Modeling and Analysis, 1990. Proceedings., First International Symposium on , 3-5 Dec. 1990

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1 Creating knowledge-based multimedia applications

Lloyd, P.R.;

Multimedia: the Future of User Interfaces, IEE Colloquium on , 26 Nov 1990

Pages:4/1 - 4/4

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Knowledge and Data Engineering, IEEE Transactions on , Volume: 8 , Issue: 1 , Feb. 1996

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